

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

# PRODUCT/PROCESS CHANGE NOTICE (PCN)

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PCN #: <b>A0609-01</b> DATE:	9/29/2006	MEANS OF DISTINGUISHING CHANGED DEVICES:				
Product Affected: 655L, 24.5x19.5mm FCBGA		☐ Product Mark				
(See attached affected part #	list)	□ Back M				
Date Effective: 12/29/2006		☐ Date Co ☐ Other		l have "SP" prefix		
		- Otner		1		
Contact: Bimla Paul		A 44 1 4	<b>*** *</b> 7.			
Title: Product Quality Assurance Phone #: (408) 574-6419		Attachment	Yes	s		
Fax #: (408) 284-8362		Samples:	Discourse	.111		
E-mail: Bimla.Paul@idt.com		Samples.	sample request & a	local sales representative for		
<u> </u>			sample request & a	variaomity.		
DESCRIPTION AND PURPOSE OF CHANGE	:					
☐ Die Technology ☐ Wafer Fabrication Process	This notification is to advise our customers that IDT has added SPIL,					
☐ Assembly Process		Taiwan as an alternate Assembly facility for 655L, 24.5x19.5mm				
☐ Equipment	•	FCBGA package. There is no change to the moisture performance of				
☐ Material	the package	as a result of	this change.			
☐ Testing  ■ Manufacturing Site	Dlanca saa n	Please see attached for the qualification data and affected next number				
<ul><li>■ Manufacturing Site</li><li>□ Data Sheet</li></ul>	list.	lease see attached for the qualification data and affected part number				
Other						
Other						
RELIABILITY/QUALIFICATION SUMMARY	<b>Y:</b>					
Please refer to the attached Qualification & Reliab	ility data.					
CUSTOMER ACKNOWLEDGMENT OF REC	CEIPT:					
IDT records indicate that you require written notification of this change. Please use the acknowledgement below or E-Mail						
to grant approval or request additional information. If IDT does not receive acknowledgement within 30 days of this notice						
it will be assumed that this change is acceptable.						
IDT reserves the right to ship either version manufactured after the process change effective date until the inventory						
on the earlier version has been depleted.						
Customer:		Appro	val for shipments	s prior to effective date.		
Name/Date:	_ E-1	Mail Address	:			
Title:	_ Ph	Phone# /Fax# :				
CUSTOMER COMMENTS:						
IDT ACKNOWLEDGMENT OF RECEIPT:						
		D				
RECD. BY:		DATE:				

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## PRODUCT/PROCESS CHANGE NOTICE (PCN)

#### **ATTACHMENT I - PCN # : A0609-01**

**PCN Type:** Manufacturing Site - Alternate Assembly Location

**Data Sheet Change:** None

No change in moisture sensitivity level (MSL)

### **Detail Of Change:**

This notification is to advise our customers that IDT has added SPIL, Taiwan as an alternate Assembly facility for 655L, 24.5x19.5mm FCBGA package. The assembly material set for SPIL assembly location is listed in Table 1.

There is no change in the moisture sensitivity level (MSL) as a result of this change.

Attachment I outlines the qualification data and affected part#s.

#### Table 1

Description	Existing	Add
Assembly Location	AMKOR Philippines, Korea and Taiwan, STATSChipPAC, Korea	SPIL, Taiwan
Assembly Material	95Pb/5Sn (High Pb Bump), NAU6 or CRP-4152RA (Underfill), TTG3 (Thermal Grease), 96.5Sn/3Ag/0.5Cu (Solder Ball)	95Pb/5Sn (High Pb Bump), U8439-1 (Underfill), TTG3 (Thermal Grease), 96.5Sn/3Ag/0.5Cu (Solder Ball)

#### Sample Availability:

Samples are already available for customer evaluation.

Please contact your local IDT sales representative for your sample request and availability.



# PRODUCT/PROCESS CHANGE NOTICE (PCN)

### ATTACHMENT I - PCN #: A0609-01

## **Qualification Information and Qualification Tests Result:**

**Test Vehicles:** 31 x31 mm FCBGA, 740 balls (1 assembly lot)

Test Description	Test Method	Test Results (SS/ Rej)
* Temperature Cycling (-40°C to +125°C, 1000 cycles)	JESD22-A104	45/0
* HAST (110°C / 85% RH, 264 hours)	JESD22-A110	45/0
High Temperature Stabilization Bake (150 °C, 1000 hours)	JESD22-A103	45/0
Moisture Sensitivity Classification, L4	J-STD-020	90/0

**Notes:** \* Test requires moisture pre-conditioning sequence per JESD22-A113.

Affected Part #s

IDTAMB0480A5RH IDTAMB0480A5RJ